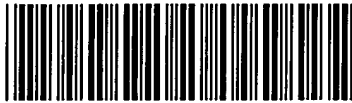


**Search Notes**

Application/Control No.

10/033,204

Examiner

Pierre-Michel Bataille

Applicant(s)/Patent under  
Reexamination

TIAN, LIJUN

Art Unit

2186

**SEARCHED**

Class	Subclass	Date	Examiner
711	154 ; 167	10/26/2006	PMB
375	242 ; 244		
375	241 ; 145		
375	342		

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
711	167 ; 154	10/26/2006	PMB
375	242		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
West Search	10/26/2006	PMB